

Test report No.

: 27LE0315-HO-B-R1

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Issued date Revised date : August 27, 2007 : September 7, 2007

FCC ID

: OUCG8D640MRAM-NU

RADIO TEST REPORT

Test Report No.: 27LE0315-HO-B-R1

Applicant

: OMRON Corporation

Type of Equipment

Receiver and Antenna Module

Model No.

G8D-640M-RAM-NU

Test standard

FCC Part 15 Subpart C

Section 15.209: 2007

FCC ID

OUCG8D640MRAM-NU

Test Result

Complied

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with above regulation.
- 4. The test results in this report are traceable to the national or international standards.
- 5. Original test report number of this report is 27LE0315-HO-B.

:

:

Date of test:

August 8 to 22, 2007

Tested by:

Takahiro Hatakeda EMC Services

Approved by:

Mitsuru Fujimura EMC Services



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.

*As for the range of Accreditation in NVLAP, you may refer to the WEB address, http://uljapan.co.jp/emc/nvlap.htm

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MF060b (18.06.07)

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SECTION 1: Client information

Company Name : OMRON Corporation

Address : 6368 Nenjozaka Okusa Komaki-City Aichi-Pref., 485-0802 Japan

Telephone Number : +81-568-78-6392 Facsimile Number : +81-568-78-6179 Contact Person : Masashi Matsuda

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Receiver and Antenna Module

Model No. : G8D-640M-RAM-NU

Sample No. : 9200 Country of Manufacture : Japan Rating : DC12V

Receipt Date of Sample : August 3, 2007 Condition of EUT : Production prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No modification by the test lab.

2.2 Product Description

Model No: G8D-640M-RAM-NU (referred to as the EUT in this report) is the Receiver and Antenna Module.

Clock Frequencies : 8MHz Equipment Type : Transceiver

[Transmitter]

Frequency of Operation : 125kHz
Type of Modulation : ASK
Power Control : No

Antenna Type : Keycoil antenna

Operating Voltage (inner) : DC5.0V

[Receiver]

Receiving Frequency : 125kHz Operating Voltage (inner) : DC5.0V

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part15 Subpart C: 2007

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional

Radiators

Section 15.207 Conducted Emission

Section 15.209 Radiated emission limits, general requirements

FCC 15.31 (e)

The power supply of the EUT is transformed to DC5.0V and the stable voltage DC5.0V is constantly provided to Radio part.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin *0)	Results
1	Conducted Emission	<fcc> ANSI C63.4:2003 7. AC powerline conducted emission measurements <ic> RSS-Gen 7.2.2</ic></fcc>	<fcc> Section 15.207 <ic> RSS-Gen 7.2.2</ic></fcc>	-	N/A *1)	N/A	N/A
	Electric Field Strength of Fundamental Emission	<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.8, 4.11</ic></fcc>	<fcc> Section 15.209 <ic> RSS-210 2.6, 2.7</ic></fcc>	Radiated	N/A	33.7dB 125.10kHz 0 deg. AV	Complied
	Electric Field Strength of Spurious Emission	<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.9, 4.11</ic></fcc>	<fcc> Section 15.209 <ic> RSS-210 2.6, 2.7</ic></fcc>	Radiated	N/A	14.2dB 120.087MHz, Vert., QP	Complied
4	-26dB Bandwidth	<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic></ic></fcc>	<fcc> Reference data <ic> -</ic></fcc>	Radiated	N/A	N/A	N/A

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

3.3 Addition to standards

No	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied	RSS-Gen 4.6.1	RSS-Gen 4.6.1	Radiated	N/A	N/A	N/A
	Band Width						

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^{*0)} The test result is round off to one or two decimal place, so some differences might be observed.

^{*1)} The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

^{*}These tests were performed without any deviations from test procedure except for additions or exclusions.

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Spurious Emission (Radiated)

The measurement uncertainty for this test using Loop antenna is $\pm 4.41 dB(3m) / \pm 4.39 dB(10m)$.

The measurement uncertainty for this test using Biconical antenna is ± 4.59 dB(3m)/ ± 4.58 dB(10m).

The measurement uncertainty for this test using Logperiodic antenna is $\pm 4.62 dB(3m)/\pm 4.60 dB(10m)$.

The measurement uncertainty for this test using Horn antenna is $\pm 5.27 dB$.

The data listed in this test report has enough margin, more than the site margin.

Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is ± 3.0 dB.

The data listed in this test report has enough margin, more than the site margin.

3.5 **Test Location**

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	IC4247-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-

^{*} Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

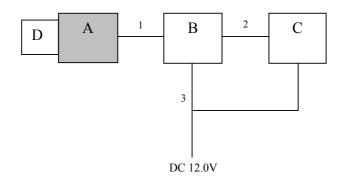
4.1 Operating Modes

The mode is used: Transceiver 125kHz

Justification : The system was configured in typical fashion (as a customer would normally use it)

for testing.

4.2 Configuration and peripherals



^{*} Cabling and setup were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

Descri	Description of E01 and Support equipment							
No.	Item	Model number	Serial number	Manufacturer	Remarks			
A	Receiver and Antenna Module	G8D-640M-RAM-NU	9200	OMRON	EUT			
В	KOS ECU	G8D-640M-ECU		OMRON	-			
C	Simulator	-	-	OMRON	-			
D	Key	-	-	OMRON	-			

List of cables used

No.	Name	Length (m)	Shield		
			Cable Connector		
1	DC & Signal Cable	1.4	Unshielded	Unshielded	
2	Signal Cable	1.4	Unshielded	Unshielded	
3	DC Cable	1.4	Unshielded	Unshielded	

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SECTION 5: Radiated emission (Fundamental and Spurious Emission and -26dB Bandwidth)

Test Procedure

The Radiated Electric Field Strength intensity has been measured on No. 2 and 3 semi anechoic chamber with a ground plane and at a distance of 3m.

Frequency: From 9kHz to 30MHz at distance 3m

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for each antenna angle 0deg., 45deg. and 90deg.

Frequency: From 30MHz to 1GHz at distance 3m

The measuring antenna height varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

Measurements were performed with a QP, PK, and AV detector.

The radiated emission measurements were made with the following detector function of the test receiver.

	From 9kHz to 90kHz	From	From	From	From
	and	90kHz to	150kHz	490kHz to	30MHz to
	From 110kHz to	110kHz	to 490kHz	30MHz	1GHz
	150kHz				
Detector Type	PK/AV	QP	PK/AV	QP	QP
IF Bandwidth	200Hz	200Hz	9kHz	9kHz	120kHz

⁻ The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

With the position, the noise levels of all the frequencies were measured.

* Part 15 Section 15.31 (f)(2) (9kHz-30MHz)

[Limit at 3m]=[Limit at 300m]- $40 \times \log (3[m]/300[m])$ [Limit at 3m]=[Limit at 30m]- $40 \times \log (3[m]/30[m])$

Test data : APPENDIX 3

Test result : Pass

Date: August 8 to 22, 2007 Test engineer: Takahiro Hatakeda

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